# E lectric and m agnetic eld optim ization

procedure for Penning trap m ass

spectrom eters

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#### A bstract

Signi cant system atic errors in high-precision Penning trap m ass spectrom etry can result from electric and m agnetic eld imperfections. An experimental procedure to m in in ize these uncertainties is presented for the on-line Penning trap m ass spectrom eter ISO LTRAP, located at ISO LDE/CERN. The deviations from the ideal m agnetic and electric elds are probed by m easuring the cyclotron frequency and the reduced cyclotron frequency, respectively, of stored ions as a function of the time between the ejection of ions from the preparation trap and their capture in

the precision trap, which in uences the energy of their axialm otion. The correction param eters are adjusted to m in im ize the frequency shifts.

K ey words: Penning trap, ion m otion, optim ization, high-precision m ass m easurem ents.

PACS: 07.75 h M ass spectrom eters, 29.30 A jC harged-particle spectrom eters: electric and m agnetic, 32.10 B i A tom ic m asses, m ass spectra, abundances, and isotopes, 96.60 H v E lectric and m agnetic elds

# 1 Introduction

The m ass of a nuclide is a fundam ental property since it gives access to the binding energy which re ects the net e ect of all forces at work in the nucleus  $[1]$ . It is of in portance for various elds such as atom ic physics, chem istry, nuclear structure, astrophysics, and the study of the weak interaction. Because the binding energy is sm all compared to the overall atom ic m ass, the required m easurem ent accuracy is necessarily high.

Of the many techniques used for mass measurements, the Penning trap has em erged as the instrum ent of choice for high precision [2], achieving a relative uncertainty of down to the order of 10  $^{11}$  on stable nuclides [3], which allow s the probing of even the atom ic binding energy. For radioactive species, ISO LTRAP [4,5], boated at the ISO LD E/CERN facility [6], has been the pioneering Penning trap experim ent for on-line m ass m easurem ents of short-lived nuclei, m eanwhile routinely reaching a relative m ass uncertainty of  $m = m$ 

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10  $8$  [\[7\]](#page-22-6). ISO LTRAP has continuously in proved its accuracy and applicability.Exam ples are the installation ofa linear radiofrequency quadrupole ion quide and beam buncher  $[8]$ , the introduction of m ass spectrom etry of ions produced by in-trap decay  $[9]$ , the system atic study of the m easurem ent uncertainties using carbon-cluster ions  $[7,10,11]$  $[7,10,11]$  $[7,10,11]$ , the im plem entation of a m agnetron phase  $\operatorname{bcking}$  m echanism  $[12]$ , and the use of R am sey's technique for the excitation of the ion  $m$  otion  $[13,14]$  $[13,14]$ .

ISO LTR A P has been followed by other Penning trap m ass spectrom eters, which are in operation or in preparation  $[2,15]$  $[2,15]$ : SM ILETRAP using stable, highly charged ions  $[16]$ , the Canadian Penning Trap $[17]$ , JYFLTRAP $[18]$ , SH IPTRAP [\[19\]](#page-23-6), LEBIT [\[20\]](#page-23-7), and TITAN [\[21\]](#page-23-8). New on-line trapsare now being com m issioned: M LLTRAP at M unich [\[22\]](#page-23-9) and TR IG A -TRAP at the research reactor TR IG A M ainz [\[23\]](#page-23-10). Form ass m easurem ents in Penning traps, m ost of the system atic errors arise from m isalignm ent and m agnetic- and electric- eld im perfections (see  $[4]$ ). Therefore, all of the system s m entioned above have to dealwith sim ilar problem s concerning the optim ization of the electric and m agnetic trapping elds. In the case of ISO LTRAP, the m echanicalm isalignm ent was m inim ized during the installation.The present work addresses the optim ization of the m agnetic and electric elds.

### 2 Ion m otion in a P enning trap

In the following, the principles and properties of a Penning trap will be brie y reviewed asfarasthey apply to high-precision m assm easurem ents.Fora m ore detailed description of the theoretical aspects of Penning traps, see  $[24,25,26]$  $[24,25,26]$  $[24,25,26]$ .



<span id="page-3-0"></span>Fig. 1. Left: G eom etry of a hyperboloidal Penning trap. Right: Schem atic representation of an ion trajectory, which is a superposition of the three eigenm otions in a Penning trap.

A n idealPenning trap isde ned asthe superposition ofa hom ogeneousm agnetic eld B and an electrostatic quadrupole eld  $V($ ; z) coaxial to the m agnetic eld. The combination of these particular elds allows to store charged particles in a well-de ned volum e. A lso, there is an exact solution of the equations of m otion in the case of a single stored ion.

The electrostatic quadrupole  eld can be obtained by an electrode con gu-ration as shown in Fig[.1](#page-3-0) (left): two endcaps and a ring electrode, all being hyperboloids of revolution.

A potential di erence  $V_0$  (the trapping potential) between the endcaps and the ring electrode creates the quadrupolar potential

$$
V ( ;z) = \frac{V_0}{4d^2} (2z^2 \t 2); \t (1)
$$

The characteristic trap dim ension d is determ ined by

$$
4d^2 = (2z_0^2 + \tfrac{2}{0}); \t\t(2)
$$

where  $_0$  is the inner radius of the ring electrode and  $2z_0$  the distance between the endcaps, as shown in Fig.1 (left).

In a purem agnetic eld the stored particle with m assm and charge q perform s a circular m otion at the cyclotron frequency

$$
_{c}=\frac{q}{2\ \text{m}}B:\tag{3}
$$

In the presence of the quadrupolar electrostatic eld the ion motion becom es a superposition of three independent harm onic motions as illustrated in Fig.1 (right). The ions have an axial oscillation mode with frequency

$$
z = \frac{1}{2} \frac{\frac{1}{\text{d}V_0}}{\text{m d}^2} \tag{4}
$$

and two circular radialm odes, the cyclotron and the magnetron motion with eigenfrequencies <sub>+</sub> (reduced cyclotron frequency) and (magnetron frequency), respectively, given by

<span id="page-4-1"></span>
$$
= \frac{c}{2} \frac{\frac{2}{c}}{\frac{c}{4}} \frac{\frac{2}{2}}{2};
$$
 (5)

The sum of the two radial eigenfrequencies obeys the relation:

<span id="page-4-0"></span>
$$
c = + + \qquad ; \qquad (6)
$$

A direct excitation of the ion m otion at this sum frequency with an azim uthally quadrupolar rf eld 25] allows a m ass determ ination of the stored ion which relies only on the m agnetic  $e$  eld B. At the same time  $e$  is a sensitive probe of the m agnetic eld strength experienced by the ions and will be used for the m agnetic eld optim ization. In contrast, for the optim ization of the electric eld the reduced cyclotron frequency  $_{+}$  will be investigated.

A nother in portant relation between the eigenfrequencies with respect to m ass spectrom etry is the so called Invariance Theorem [\[27\]](#page-23-14):

$$
c^{2} = \frac{2}{1} + \frac{2}{1} + \frac{2}{z};
$$
 (7)

which is independent of eld im perfections to rst order. However, since only Eq. [\(6\)](#page-4-0) is applied in high-precision Penning trap m ass m easurem ents on shortlived nuclides, the largest source of uncertainties are electric and m agnetic eld im perfections that cause a broadening and a shift of the cyclotron frequency resonance.These im perfections are due to the fact that a realPenning trap deviates from the idealcase in m any aspects  $[4,24]$  $[4,24]$ . In the following, the electric and m agnetic  eld im perfections and their m inim ization are discussed using the ISO LTRAP m ass spectrom eter as an exam ple.

### 3 E xperim entalsetup

ISO LTR A P is a high-precision Penning trap m ass spectrom eter consisting of three m ain parts (see Fig[.2\)](#page-6-0) [\[5\]](#page-22-4): First, a gas-lled radio-frequency quadrupole (R FQ ) trap serves as a cooler and buncher to adapt the 60-keV ISO LD E ion beam to the ISO LTRAP requirem ents with respect to kinetic energy,



<span id="page-6-0"></span>Fig. 2. Experim ental setup of the ISO LTRAP m ass spectrom eter with the three m ain parts: A gas-lled linear radio-frequency quadrupole (R FQ ) trap, a gas-lled cylindrical Penning trap, and a high-vacuum hyperboloidal Penning trap. For the tim e-ofightm easurem enta Channeltron detector is installed 1.2m upstream [\[28\]](#page-23-15). The inset shows a m ore detailed illustration of the precision Penning trap.

tim e structure, and beam em ittance [\[8\]](#page-22-7). Second, a high-capacity cylindrical Penning trap is used for isobaric cleaning of the beam by exploiting a m assselective helium -bu ergas cooling technique  $[29]$  with a resolving power of up to  $10^5$  [\[30\]](#page-23-17). Finally, the cooled ion bunch is transferred to the precision Penning trap where the m ass m easurem ent is carried out by the determ ination of the cyclotron frequency of the stored ions, using a time-of- ight (ToF) detection m ethod[\[31\]](#page-23-18): A fter a dipolar radiofrequency (rf) excitation of the ions to a m agnetron orbit of about  $0.7-1.0$  m m radius [\[12\]](#page-22-11), the initially pure m agnetron m otion is converted into cyclotron m otion by a quadrupolar rf eld  $\beta$ 2]. At  $r_f$  = c a full conversion from initially pure m agnetron to pure cyclotron m otion is obtained. In this case, the orbitalm agnetic m om ent and the radial



<span id="page-7-0"></span>Fig. 3. Cyclotron resonance of  ${}^{85}Rb^+$  ions recorded for an excitation duration of 900m s. The solid line is a tof the line shape to the data points.

kinetic energy  $E = B$  are increased. The ions are ejected from the trap and their ToF to an ion detector is m easured.Since there is an axialacceleration of the ions in the fringe eld of the superconducting m agnet, which is proportionalto , the shortest ToF is observed for  $r_f = c$ . Figure 3 shows a typical resonance where the ToF is m easured as a function of the frequency  $_{rf}$  of the excitation eld applied. The m ass of the ion of interest is obtained from the com parison of its cyclotron frequency with that of a well-known "reference m ass", provided from either ISO LD E or an o -line reference ion source. The m easurem ent procedure as well as the study of the accuracy  $\text{Im } \text{it}$  and system atic uncertainties are described in detail in  $[7]$ .

## 3.1 M agnetic eld im perfections

In order to perform a high-precision cyclotron-frequency m easurem ent, excellent hom ogeneity and tem poral stability of the m agnetic eld are required. Here, the possibility to m inim ize m agnetic  $\Box$  eld inhom ogeneities by a dedicated optim ization procedure is addressed. The temporal stability is discussed in  $[7,33]$ .

M agnetic eld imperfections arise from the hom ogeneity limits of commercial superconducting m agnets: now adays an inhomogeneity of typically  $B = B <$ 10 $^{-7}$  can be provided over a volum e of about a cubic centimeter. The volume typically probed by the ions during precision m ass m easurem ents results from the am plitudes a  $1mm$  and  $a_z$  1mm of the radial and axial motional m odes, respectively. During the optim ization the axial am plitudes are varied and increased on purpose by up to an order of m agnitide (see below). For com parison, the precision trap has dim ensions  $_0 = 13.00$  m m and  $z_0 = 11.18$  m m. In addition to the intrinsic inhom ogeneity of the superconducting magnet, the hom ogeneity can be disturbed if m aterials (including trap com ponents) with a m agnetic susceptibility are introduced into the m agnetic eld. To m in m ize this problem, the ISO LTRAP electrodes are made from oxygen-free copper and the amount of material closest to the trap center was min mized.

There are higher order m agnetic eld components that must be m in m ized. Due to the m intor symmetry (with respect to the xy-plane through the trap center) only even components occur. In addition, odd terms do not matter since they do not result in frequency shifts, assum ing that the average center of the ion m otion does not change. The frequency shift caused by m agnetic eld inhom ogeneities can be approximated by 24]

$$
Cc \text{ and } C2 = 2 \text{ and } C2 = 2 \text{ and } C2 = 2 \tag{8}
$$

where  $\frac{1}{2}$  denotes the relative strength of the lowest-order com ponent of m aq-



<span id="page-9-0"></span>Fig. 4. A section of the m easurem ent trap, which is installed in a superconducting m agnet (lateralcut) that generates a m agnetic eld B in the axialdirection. Several superconducting shim coils and room -tem perature shim coils are shown.The correction for m agnetic eld inhom ogeneities is done using the latter.Points and crosses represent the current direction out of and into the plane, respectively.

netic inhom ogeneities.

The precision Penning trap (see inset of  $F$  ig[.2\)](#page-6-0) is placed in a 5.9-T m agnetic eld generated by a superconducting solenoid. To provide a hom ogeneousm agnetic eld them agnet is equipped with a set of superconducting shim coils and a set of room -tem perature shim coils (see Fig[.4\)](#page-9-0). The current on all superconducting shim coils was optim ized during the installation of the magnet. For practicaluse,only the room -tem perature shim coils are optim ized routinely. The three coils closest to the trap (dashed boxes in  $F$  ig[.4\)](#page-9-0) have the strongest in uence on the eld distribution and thus on the eld hom ogeneity along the z-axis inside the trap. Consequently, the optim ization param eter is the current  $I<sub>S</sub>$  applied simultaneously to these three room-tem perature shim coils. This current induces a m agnetic  eld oriented in one direction for the two outer

coils and in the opposite direction for the inner one (see  $F$  ig. 4), thus allow ing to shim the  $z^2$ -com ponent of the m agnetic eld, which can be approximated along the axial direction by

$$
B(z) = B_0(1 + b_1 z^2 + b_2 z^4 + \dots); \tag{9}
$$

Only the  $z^2$ -com ponent is addressed since the axial am plitudes are in general much larger than the radial ones and odd-term s cancel out.

### 3.2 Electric eld imperfections

Electric eld in perfections arise from deviations of the mechanical trap construction from the ideal hyperbolical shape, such as holes in the endcaps for in jection or ejection of ions and the unavoidable truncation of the electrodes. Thus, the electric eld inside the trap does not follow the pure quadrupolar form. However, it needs to be as ideal as possible in order to assure the exact condition given in Eq.  $(6)$ .

For a real Penning trap the potential inside the trap can be expanded in the fom [25]:

$$
V ( ; z) = \frac{1}{2} V_0^4 \frac{C_2}{d^2} z^2 \frac{1}{2} z + \frac{C_4}{d^4} z^4 \frac{3z^2}{2} z^2 + \frac{3}{8} z^4
$$
  
+  $\frac{C_6}{d_6} z^6 \frac{15}{2} z^4 z + \frac{45}{8} z^2 z^4 \frac{5}{16} z + ::5 :$  (10)

with  $C_2$  as the quadrupole component. In an ideal trap  $C_2 = 1$  and  $C_n =$ 0 for n > 2. The frequency shift  $e^{elec}[4]$ , which is due to the octupole

(represented by  $C_4$ ) and dodecapole  $(C_6)$  contributions, depends on the ionm otion am plitudes  $a_+$ ,  $a_7$ ,  $a_7$  of the cyclotron, m agnetron, and axialm otion, respectively, and is given by

$$
e^{abc} = \frac{V_0}{4 d^2 B} \frac{3 C_4}{2 d^2} (a^2 a_+^2)
$$
  
+ 
$$
\frac{15 C_6}{4 d^4} a_2^2 (a^2 a_+^2) (a^4 a_+^4)^5
$$
: (11)

To m in in ize the imperfections, additional electrodes are in plem ented in the precision Penning trap: two correction rings and two correction tubes, as shown in Fig.2, to elim inate  $C_4$  and  $C_6$ . W ithout these additional electrodes the m ultipole contributions to the potential are C<sub>2</sub> = 0.96, C<sub>4</sub> = 0.23, and C<sub>6</sub> =

0.26 as deduced from simulations. The correction ring electrodes lead to contributions of C<sub>4</sub> = 5:5 10<sup>4</sup> and C<sub>6</sub> = 1:5 10<sup>4</sup> and have only an in uence on the  $C_2$ -value of the order of 1.6 10<sup>5</sup>. Sim ilarly, the correction tube electrodes lower the multipole contributions to C<sub>4</sub> = 5.6 10<sup>3</sup> and  $C_6 = 9.0$  10<sup>3</sup> and have an e ect on  $C_2$  of the order of 5.4 10<sup>3</sup>. The rem aining deviations from a pure quadrupolar eld are far away from the ion tra jectory, since for typical precision m ass m easurem ents the am plitude of the axialm otion does not exceed 1mm.

# 4 Field-optim ization results

#### 4.1 Probing the eld imperfections

The electric eld optimization consists of varying the voltages of the correction rings and correction tubes and m onitoring the e ect on the reduced cyclotron frequency while the trapping conditions are varied. A fter the bu er-gas cooling in the rst Penning trap the axial energy of the ions is therm alized to room tem perature. From there the ions are ejected and accelerated towards the precision Penning trap. They are captured by, rst, retarding them in the trap center while the potential of the lower endcap has been lowered and, second, restoring the potential of the lower endcap to its original value. The capture time  $T_{cap}$ , a key param eter in the eld-optim ization procedure, is de ned as the tim e between the ejection from the preparation Penning trap and the rising of the lower endcap potential in the precision trap.

D epending on both the initial axial energy distribution of the ions and the capture tim e in the precision trap, the stored ions have di erent axial energies and thus exhibit trajectories which m ay cover a sm aller or larger volum e in the trap. Therefore, them agnetic eld and the quadrupolar electric eld in the precision trap should have as little as possible deviation from the ideal elds in order to give the sam e conditions irrespective of the initial axial energy after capturing. By the same token, the resonance frequencies can be m easured as a function of the capture time in order to probe the eld imperfections.

In general, before ejection towards the last ion detector (see Fig[.2\)](#page-6-0), the trappingpotentialdepth islowered by ram pingofthepotentialoftheringelectrode (see [\[28\]](#page-23-15)fordetails).In orderto dem onstrate thein
uenceofthecapturetim e on the axial energy of the ions, the release of ions from the trap during this ram ping and at the m om ent of pulsing the endcap ism onitored as a function of the capture tim e. Fig[.5](#page-13-0) (top) show sthree ToF spectra accum ulated for different ranges of the capture tim e  $T_{cap}$ , where the tim e  $t=0$  m arks the start of the ram ping of the ring elecrode potential from  $10V$  to  $2.5V$ , which lasts 17.5m s.



<span id="page-13-0"></span>Fig. 5. Top: T im e-of-ight spectra of  ${}^{85}Rb^+$  ions being released from the precision Penning trap towards the detector for dierent ranges of the capture time  $T_{cap}$  (see text for details). Bottom : N um ber of captured ions as a function of the capture  $\tan$  e for  ${}^{85}$ Rb<sup>+</sup>. The full sym bols correspond to all ions stored after ion capture. The open triangles denote ions which are released during the ram ping of the ring potnetial (range "A" in the ToF spectrum). The open circles (curve lled with a gray area) correspond to the num ber of ions that rem ain in the trap after lowering the capture potentialdepth (range "B" in the ToF spectrum ).

Ionswith a higheraxialenergy than the trapping potentialdepth arereleased and m ay reach the detector producing a signal in the time range "A". A fter 19.5m sthe endcap potentialispulsed and allionsstillstored in the trap are ejected. These ions produce the signal in the time range "B". W hile stored in the trap, they have low axialenergies and thus low axialam plitude. In the norm aloperation m ode for precision m ass m easurem ents, only the corresponding capture tim e is applied. For the present study, however, the capture time will be varied system atically to observe its e ect on the resonance frequencies.

Fig[.5](#page-13-0)(bottom ) gives the num ber of ions before and during the ram ping of the ring electrode (open triangles) and after the ram ping (open circles) as a function of the capture time. The full circles correspond to the sum of all ions stored in the precision trap after capturing. The axial energy of the stored ions after capturing is m ainly in
uenced by the initialenergy ofthe ions as they leave the preparation trap: ions  $w$  ith low axial kinetic energy arrive at a later tim e than ions with higher axialkinetic energy relative to the capture tim e in the precision trap. In addition, ions with high axial kinetic energy m ay be re
ected back to the trap center by the upper endcap potential.A ltogether, an asymmetric distribution of ions with high and low axial kinetic energy is obtained upon variation of the capture time.

In order to investigate the eld corrections, the capture time  $T_{cap}$  is varied around the optimum value as shown in Fig[.6](#page-15-0) for  ${}^{85}R b^+$  ions. For non-optim al capture  $\tan$  es, the axial energy of the ions will be larger and deviations from the ideal electrom agnetic elds can be probed by m easuring the change of the ion-m otion frequencies as compared to the case of the optim alcapture time. Since  $_{c}$  is directly related to B and not to  $V_{0}$ , we m easure  $_{c}$  to probe the m agnetic eld and  $_+$  (related to  $V_0$ ) for the electric eld optimization.



<span id="page-15-0"></span>Fig. 6. Number of captured ions as a function of the capture time for  ${}^{85}Rb^+$ . The solid line is a Gaussian t to the data points. The FW HM of the t is 3.5 s. The dashed lines (m arked " $(1)$ " and " $(2)$ ") indicate them im im um and m axim um capture tim es as used in the present investigation.

4.2 M agnetic eld

The trim parameter for the magnetic-eld homogeneity along the z-axis is the current  $I_s$  applied to the three room -tem perature shim coils close to the trap  $(\text{see Fig.4}).$  The best value of the shim-coil current will optimize the m agnetic eld hom ogeneity over the large axial distance the ions cover, hence m in in izing frequency variations for deviating capture times and axial ion energies. To check the m agnetic eld hom ogeneity, the cyclotron frequency  $_{c}$  is taken as a probe, since it directly depends on the m agnetic  $e$ k (see Eq. 6)). The cyclotron frequency is determined via the measurement of time-of-ight resonance curves (see above) and frequency changes are probed for di erent capture times  $T_{cap}$ , i.e. in the present case between 41.7 s (1) and 47.7 s (2) for  ${}^{85}Rb^+$  (see Fig.6), and di erent shim-coil currents.



<span id="page-16-0"></span>Fig. 7. Cyclotron frequency  $_{c}$  as a function of the capture time T<sub>cap</sub> for two dierent shim-coil currents: (a)  $I_S = 350 \text{ mA}$  and (b)  $I_S = 100 \text{ mA}$ .

The importance of such an optimization is shown in Fig.7, which gives the cyclotron frequency as a function of the capture time for two extreme values of the shim-coil current. The corresponding relative frequency deviation for 2.5 s for each current setting is  $c = c = 4$  10<sup>7</sup>. Note that  $T_{\text{cap}}$  = there is a shift in absolute frequency as well as an in ection in the frequency variations. This is due to the fact that the correction coil design was made such that a B<sub>0</sub> contribution is m in m ized and the contribution to the next higher order term  $B_2$  m aximized. The shift is a small left-over because the cancelation of  $B_0$  from the outer and the inner coil is not perfect.

nd the optimum value for  $T_{cap}$ , i.e. for which  $C = 0$ , the shim-coil Τo current is varied and the frequency shift clear to between two did erent capture times (m arked as (3) with  $T_{cap} = 44.7$  s and (4) with  $T_{cap} = 47.2$  s in Fig. 7) is measured. A capture time of 47.7 swas not used because of the low capturing e ciency for this value and thus the resulting long measurement time. M oreover, it is expected that during a "norm al" m ass m easurem ent ions with the respective am ount of axial energy will not be present in the trap. The fre-



<span id="page-17-0"></span>Fig.8.Top: Cyclotron frequency  $_{\rm c}$  as a function of the variation of T<sub>cap</sub> for two extrem e values of the shim -coil current (full triangles:  $I_S = 350 \text{ mA}$ ; full squares:  $I_S$  = 100m A ) and for the interpolated optimum value  $I_S$  = 270m A (full circles). The right-hand side plot gives a zoom for the optimum shim-coil current of  $I_S = 270$  m A . Bottom : Cyclotron frequency dierence c between two capture tim es,  $T_{cap}$  = 44:7 s and 47.2 s, as a function of the shim-coilcurrent. The linear tto the data points provides the optim alvalue, i.e. where  $c = 0: I_S = 270$  3m A.

quency variation was m easured for severalshim -coil currents and the results are plotted in Fig[.8.](#page-17-0)The optim um value wasdeduced from a linear tto the data points, yielding  $I_S = 270 \text{ m A}$ .

Cyclotron frequencies  $_{c}$  obtained with this optim um value are presented in

Fig[.8](#page-17-0) (right). The relative deviation is well below  $5 \times 10^8$  for a capture time variation of 1.5 s. For a typical uncertainty in the capture-time setting of about 0.3 s the relative frequency shift is well below 1  $10^8$ . Figure 8 (left) also illustrates the overall behavior of the cyclotron frequency as a function of the applied shim -coil current, where an o set of the absolute frequency and a relative frequency shift can be observed as a function of  $T_{cap}$ . The latter lead to system atic errors thus pointing out the importance of the magnetic eld optim ization and on m aking sure that the ions are trapped in the center on average.

4.3 Electric eld

To m in in ize electric- eld im perfections, two correction rings and tubes are used as shown in Fig[.2.](#page-6-0) The correction rings correct for the nite dim ension of the electrodes while the correction tubes compensate the discontinuity in the endcap surface due to the ion entrance and exit holes. The in uence of the rings is by farm uch sm aller than the in uence of the tubes (see section  $4.3.2$ ).

### 4.3.1 Correction tubes

The two correction tubes are called "Lower Correction Tube" (LCT), and "U pper Correction Tube" (UCT). In general, the sam e voltage is applied to both tubes.This voltage is the param eter used for the optim ization of the electric eld.A gain, the capture time is used to probe the e ects of the detuned  eld on the cyclotron frequency.

The optim um value of the correction-tube voltage is found when an ideal



<span id="page-19-0"></span>Fig. 9. Top: Reduced cyclotron frequency as a function of the variation of the capture time for dieernt values of the voltages on the correction tubes  $(0.950V, 1.120V, 1.00V)$ and  $1.250V$ ; full circles) and rings (6.01V, 6.80V, and 7.83V; empty circles). The zoom shows the frequency shift for the optimum values of the correction tubes and rings voltage. Bottom: Frequency shift between two capture times ( $T_{cap}$  = 44.7 s and 47.2 s) as a function of the correction tubes voltage. The linear interpolation provides the optimal value: (1:120  $0:003)V$  for  $_{+}$  = 0.

eld is realized in the trap and therefore no frequency shifts occur for electric all capture times between 41.7 s and 47.7 s (see Fig. 6). For the electric eld optim ization, the reduced cyclotron frequency  $\frac{1}{1}$  is m on itored (see Eq.(5)). Them agnetic eld optim ization was performed rst to ensure that B and thus  $_{c}$  are constant along the axial direction of the trap. C onsequently the variation

of  $+$  is directly related to the electric eld via  $V_0$  with the approxim ation  $_{+}$  = c V<sub>0</sub>=4 B d<sup>2</sup>.

Figure 9 (top) presents a m easurem ent of the reduced cyclotron frequency as a function of the capture time for dierent values of the correction-tube and -ring voltage. The observed curvatures with large relative frequency deviations

= show the importance of the electric- eld optimization.

To determ ine the optim um value, the frequency di erence  $+$  between two di erent capture times ( $T_{cap}$  = 44:7 s and  $T_{cap}$  = 47:2 s) is measured as a function of the correction-tube voltage. The results are plotted in Fig[.9](#page-19-0) (bottom). The optim um value with a m inim alfrequency shift  $+$  was found by interpolation to be 1.120V . R esults with this optim um value are presented in  $F$ ig[.9](#page-19-0) (top). A gain, in addition to the frequency variations caused by the variation of the capture tim e, shifts of the frequency at the optim al tim e are observed for di erent voltages. A fter the optim ization the deviation  $+ = +$ is m in inim ized to well below 1  $10^8$  for the capture-time range  $T_{\text{cap}} = (44.7)$ 1:0) s.The rem aining deviations m ay be due to tem perature 
uctuations in the  $ISOLDE$  hall  $[33]$ .

### <span id="page-20-0"></span>4.3.2 Correction rings

Figur[e9](#page-19-0) (top) shows a comparison of the in uence of the correction rings and the correction tubes. For this study the optim alvalue for the voltage applied to the correction rings and to the correction tubes (i.e. to obtain a atdependence as a function of  $T_{\rm cap}$ ) was used and also two extrem e values chosen in the same proportion for the rings and the tubes. For the m easurem ents of the in uence of the correction rings the correction tubes were set to the optim um value of

1,120V. V ice versa during the measurement of the in uence of the correction tubes, the correction rings were set to the optimum value of  $6.80V$ .

The in uence of the correction rings is about ve times sm aller than that of the tubes, so the optim ization should be focused on the tubes. This was expected from the simulations as mentioned above, which show a stronger in uence of the tubes. The di erence between the behavior observed in other system  $s\beta 4$  ] and the ISO LTRAP result is due to the fact that the axialm otion of the ions is not cooled in the precision trap. So, in the case of w rong capture times, the ions have larger axial am plitudes, com e closer to the holes in the endcaps and thus are more in uenced by the correction tubes.

### 5 Sum m ary and conclusion

In order to achieve accurate m ass values employing Penning trap m ass spectrom etry the electric and m agnetic elds in the Penning trap have to be optim ized to correct for deviations arising from geometrical trap in perfections and hom ogeneity lim its of the superconducting m agnet. The procedure for the optim ization of the electric and m agnetic eld for the precision Penning trap of ISO LTRAP has been described and demonstrated. The optim ization was perform ed by varying the capture time, i.e. the delay period between the ejection of iond from the preparation trap and the capturing in the precision trap, thus giving them di erent axial energy, i.e. changing the am plitude of their axialoscillation. Them agnetic eld was optimized rst to avoid any in uence on the electric eld optimization.

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